# PMV185XN

## **30 V, single N-channel Trench MOSFET**

**3 August 2012** 

**Product data sheet** 

### 1. Product profile

#### 1.1 General description

N-channel enhancement mode Field-Effect Transistor (FET) in a small SOT23 (TO-236AB) Surface-Mounted Device (SMD) plastic package using Trench MOSFET technology.

#### 1.2 Features and benefits

- Low R<sub>DSon</sub>
- Very fast switching
- Trench MOSFET technology

#### 1.3 Applications

- · Relay driver
- · High-speed line driver
- Low-side loadswitch
- Switching circuits

#### 1.4 Quick reference data

Table 1. Quick reference data

| Symbol                 | Parameter                        | Conditions   |     | Min | Тур | Max | Unit |
|------------------------|----------------------------------|--|-----|-----|-----|-----|------|
| V <sub>DS</sub>        | drain-source voltage             | T <sub>amb</sub> = 25 °C   |     | -   | -   | 30  | V    |
| $V_{GS}$               | gate-source voltage              |  |     | -12 | -   | 12  | V    |
| I <sub>D</sub>         | drain current                    | V <sub>GS</sub> = 4.5 V; T <sub>amb</sub> = 25 °C; t ≤ 5 s               | [1] | -   | -   | 1.2 | Α    |
| Static characteristics |                                  |  |     |     |     |     |      |
| R <sub>DSon</sub>      | drain-source on-state resistance | $V_{GS} = 4.5 \text{ V}; I_D = 1.1 \text{ A}; T_j = 25 ^{\circ}\text{C}$ |     | -   | 185 | 250 | mΩ   |

<sup>[1]</sup> Device mounted on an FR4 Printed-Circuit Board (PCB), single-sided copper, tin-plated, mounting pad for drain 6 cm<sup>2</sup>.





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### 2. Pinning information

Table 2. Pinning information

| Pin | Symbol | Description | Simplified outline | Graphic symbol                           |
|-----|--------|-------------|--------------------|--|
| 1   | G      | gate        | <u> </u>           | D<br>                                    |
| 2   | S      | source      |                    |  |
| 3   | D      | drain       | 1                  | G 13 7 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1 |
|     |        |             |                    | 017aaa253                                |

## 3. Ordering information

Table 3. Ordering information

| Type number | Package  |  |         |  |  |  |
|-------------|----------|--|---------|--|--|--|
|             | Name     | Description                              | Version |  |  |  |
| PMV185XN    | TO-236AB | plastic surface-mounted package; 3 leads | SOT23   |  |  |  |

## 4. Marking

Table 4. Marking codes

| 144010 11 11411111111111111111111111111 |              |  |  |  |  |
|---|--------------|--|--|--|--|
| Type number                             | Marking code |  |  |  |  |
|   | [1]          |  |  |  |  |
| PMV185XN                                | EH%          |  |  |  |  |

<sup>[1] % =</sup> placeholder for manufacturing site code

## 5. Limiting values

Table 5. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

| Symbol           | Parameter               | Conditions   |     | Min | Max  | Unit |
|------------------|-------------------------|--|-----|-----|------|------|
| V <sub>DS</sub>  | drain-source voltage    | T <sub>amb</sub> = 25 °C                                   |     | -   | 30   | V    |
| V <sub>GS</sub>  | gate-source voltage     |  |     | -12 | 12   | V    |
| I <sub>D</sub>   | drain current           | V <sub>GS</sub> = 4.5 V; T <sub>amb</sub> = 25 °C; t ≤ 5 s | [1] | -   | 1.2  | Α    |
|                  |                         | V <sub>GS</sub> = 4.5 V; T <sub>amb</sub> = 25 °C          | [1] | -   | 1.1  | Α    |
|                  |                         | V <sub>GS</sub> = 4.5 V; T <sub>amb</sub> = 100 °C         | [1] | -   | 0.7  | Α    |
| I <sub>DM</sub>  | peak drain current      | $T_{amb}$ = 25 °C; single pulse; $t_p \le 10 \mu s$        |     | -   | 4.4  | Α    |
| P <sub>tot</sub> | total power dissipation | T <sub>amb</sub> = 25 °C                                   | [2] | -   | 325  | mW   |
|                  |                         |  | [1] | -   | 455  | mW   |
|                  |                         | T <sub>sp</sub> = 25 °C                                    |     | -   | 1275 | mW   |

PMV185XN

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| Symbol             | Parameter            | Conditions               |     | Min | Max | Unit |
|--------------------|----------------------|--------------------------|-----|-----|-----|------|
| Tj                 | junction temperature |                          |     | -55 | 150 | °C   |
| T <sub>amb</sub>   | ambient temperature  |                          |     | -55 | 150 | °C   |
| T <sub>stg</sub>   | storage temperature  |                          |     | -65 | 150 | °C   |
| Source-drain diode |                      |                          |     |     |     |      |
| I <sub>S</sub>     | source current       | T <sub>amb</sub> = 25 °C | [1] | -   | 0.7 | Α    |

- [1] Device mounted on an FR4 Printed-Circuit Board (PCB), single-sided copper, tin-plated, mounting pad for drain 6 cm<sup>2</sup>.
- [2] Device mounted on an FR4 Printed-Circuit Board (PCB), single-sided copper, tin-plated and standard footprint.

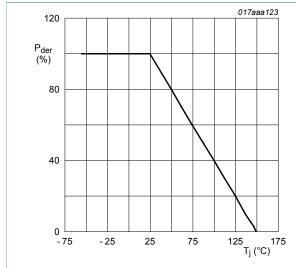


Fig. 1. Normalized total power dissipation as a function of junction temperature

$$P_{der} = \frac{P_{tot}}{P_{tot(25^{\circ}C)}} \times 100 \%$$

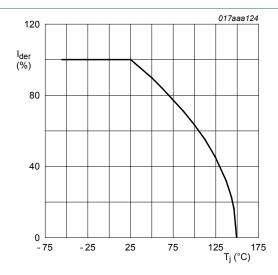


Fig. 2. Normalized continuous drain current as a function of junction temperature

$$I_{der} = \frac{I_D}{I_{D(25^{\circ}\text{C})}} \times 100 \%$$

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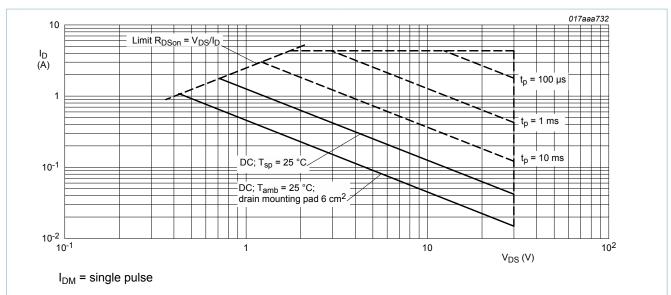


Fig. 3. Safe operating area; junction to ambient; continuous and peak drain currents as a function of drain-source voltage

#### 6. Thermal characteristics

Table 6. Thermal characteristics

| Symbol   | Parameter  | Conditions           |     | Min | Тур | Max | Unit |
|--|--|----------------------|-----|-----|-----|-----|------|
| R <sub>th(j-a)</sub> thermal resistance from junction to ambient |  |                      | [1] | -   | 333 | 385 | K/W  |
|  |  |                      | [2] | -   | 240 | 275 | K/W  |
|  | ambient  | in free air; t ≤ 5 s | [2] | -   | 203 | 235 | K/W  |
| R <sub>th(j-sp)</sub>  | thermal resistance from junction to solder point |                      |     | -   | 85  | 100 | K/W  |

- [1] Device mounted on an FR4 PCB, single-sided copper, tin-plated and standard footprint.
- [2] Device mounted on an FR4 PCB, single-sided copper, tin-plated, mounting pad for drain 6 cm<sup>2</sup>.

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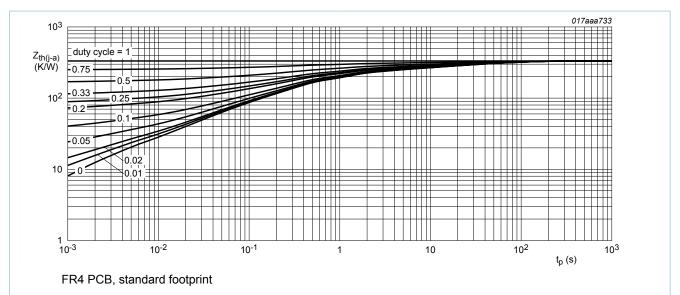


Fig. 4. Transient thermal impedance from junction to ambient as a function of pulse duration; typical values

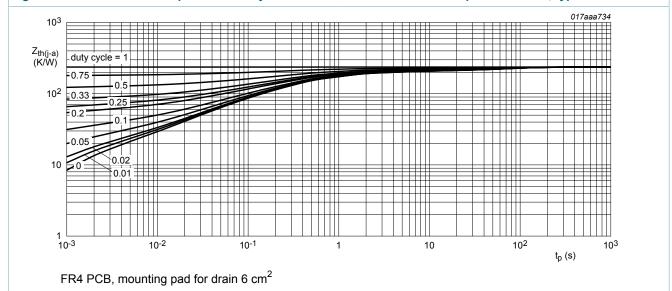


Fig. 5. Transient thermal impedance from junction to ambient as a function of pulse duration; typical values

#### 7. Characteristics

Table 7. Characteristics

| Symbol           | Parameter                         | Conditions   | Min | Тур | Max           | Unit            |
|------------------|-----------------------------------|--|-----|-----|---------------|-----------------|
| Static chara     | acteristics                       |  |     |     |               |                 |
| $V_{(BR)DSS}$    | drain-source<br>breakdown voltage | $I_D$ = 250 $\mu$ A; $V_{GS}$ = 0 V; $T_j$ = 25 °C                         | 30  | -   | -             | V               |
| $V_{GSth}$       | gate-source threshold voltage     | $I_D = 250 \ \mu A; \ V_{DS} = V_{GS}; \ T_j = 25 \ ^{\circ}C$             | 0.5 | 1   | 1.5           | V               |
| I <sub>DSS</sub> | drain leakage current             | V <sub>DS</sub> = 30 V; V <sub>GS</sub> = 0 V; T <sub>amb</sub> = 25 °C    | -   | -   | 1             | μA              |
|                  |                                   | V <sub>DS</sub> = 30 V; V <sub>GS</sub> = 0 V; T <sub>amb</sub> = 150 °C   | -   | -   | 10            | μA              |
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| Symbol              | Parameter                    | Conditions  | Min      | Тур  | Max | Unit |
|---------------------|------------------------------|---|----------|------|-----|------|
| I <sub>GSS</sub>    | gate leakage current         | V <sub>GS</sub> = 12 V; V <sub>DS</sub> = 0 V; T <sub>j</sub> = 25 °C     | -        | -    | 100 | nA   |
|                     |                              | V <sub>GS</sub> = -12 V; V <sub>DS</sub> = 0 V; T <sub>j</sub> = 25 °C    | -        | -    | 100 | nA   |
| R <sub>DSon</sub>   | drain-source on-state        | V <sub>GS</sub> = 4.5 V; I <sub>D</sub> = 1.1 A; T <sub>j</sub> = 25 °C   | -        | 185  | 250 | mΩ   |
|                     | resistance                   | V <sub>GS</sub> = 4.5 V; I <sub>D</sub> = 1.1 A; T <sub>j</sub> = 150 °C  | -        | 300  | 400 | mΩ   |
|                     |                              | $V_{GS} = 2.5 \text{ V}; I_D = 0.25 \text{ A}; T_j = 25 ^{\circ}\text{C}$ | -        | 255  | 365 | mΩ   |
| 9 <sub>fs</sub>     | forward transconductance     | $V_{DS}$ = 10 V; $I_{D}$ = 1.1 A; $T_{j}$ = 25 °C                         | -        | 2.9  | -   | S    |
| Dynamic cl          | haracteristics               |   | <u> </u> |      |     |      |
| Q <sub>G(tot)</sub> | total gate charge            | V <sub>DS</sub> = 15 V; I <sub>D</sub> = 1.1 A; V <sub>GS</sub> = 4.5 V;  | -        | 0.87 | 1.3 | nC   |
| Q <sub>GS</sub>     | gate-source charge           | T <sub>j</sub> = 25 °C  | -        | 0.17 | -   | nC   |
| $Q_{GD}$            | gate-drain charge            |   | -        | 0.24 | -   | nC   |
| C <sub>iss</sub>    | input capacitance            | V <sub>DS</sub> = 15 V; f = 1 MHz; V <sub>GS</sub> = 0 V;                 | -        | 76   | -   | pF   |
| C <sub>oss</sub>    | output capacitance           | T <sub>j</sub> = 25 °C  | -        | 30   | -   | pF   |
| C <sub>rss</sub>    | reverse transfer capacitance |   | -        | 22   | -   | pF   |
| t <sub>d(on)</sub>  | turn-on delay time           | V <sub>DS</sub> = 15 V; I <sub>D</sub> = 1.1 A; V <sub>GS</sub> = 4.5 V;  | -        | 7    | -   | ns   |
| t <sub>r</sub>      | rise time                    | $R_{G(ext)} = 6 \Omega; T_j = 25 ^{\circ}C$                               | -        | 11   | -   | ns   |
| t <sub>d(off)</sub> | turn-off delay time          |   | -        | 16   | -   | ns   |
| t <sub>f</sub>      | fall time                    |   | -        | 7    | -   | ns   |
| Source-dra          | in diode                     |   | l I      |      |     |      |
| V <sub>SD</sub>     | source-drain voltage         | $I_S = 0.7 \text{ A}; V_{GS} = 0 \text{ V}; T_j = 25 ^{\circ}\text{C}$    | -        | 0.8  | 1.2 | V    |

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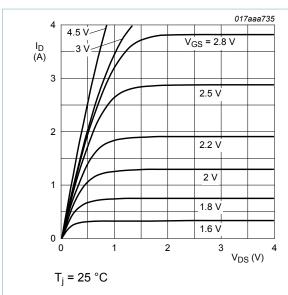
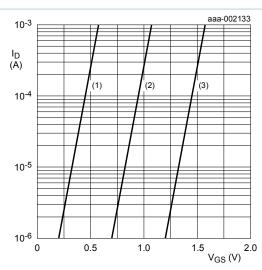


Fig. 6. Output characteristics: drain current as a function of drain-source voltage; typical values



 $T_i = 25 \,^{\circ}C; V_{DS} = 5 \,^{\circ}V$ 

- (1) minimum values
- (2) typical values
- (3) maximum values

Fig. 7. Sub-threshold drain current as a function of gate-source voltage

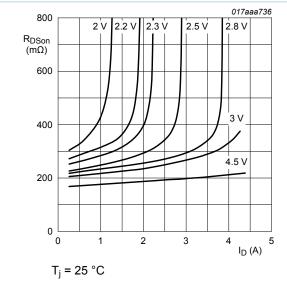


Fig. 8. Drain-source on-state resistance as a function of drain current; typical values

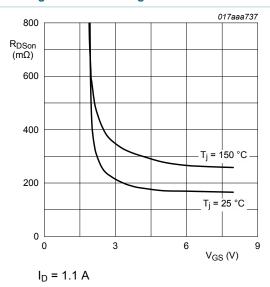


Fig. 9. Drain-source on-state resistance as a function of gate-source voltage; typical values

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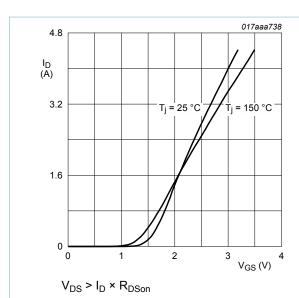


Fig. 10. Transfer characteristics: drain current as a function of gate-source voltage; typical values

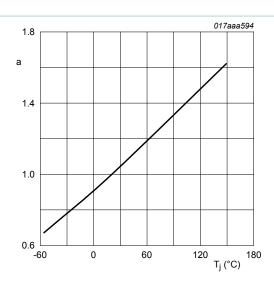


Fig. 11. Normalized drain-source on-state resistance as a function of junction temperature; typical values

$$a = \frac{R_{DSon}}{R_{DSon(25^{\circ}C)}}$$

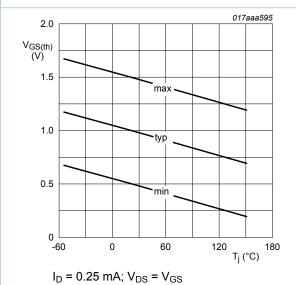


Fig. 12. Gate-source threshold voltage as a function of junction temperature

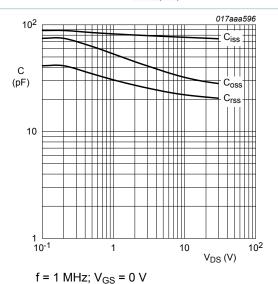


Fig. 13. Input, output and reverse transfer capacitances as a function of drain-source voltage; typical values

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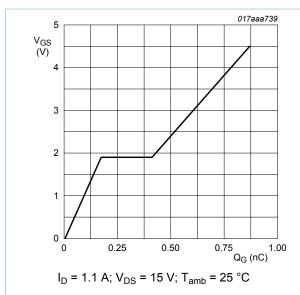


Fig. 14. Gate-source voltage as a function of gate charge; typical values

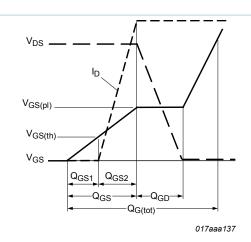


Fig. 15. Gate charge waveform definitions

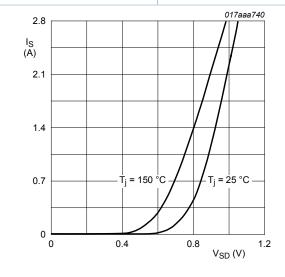
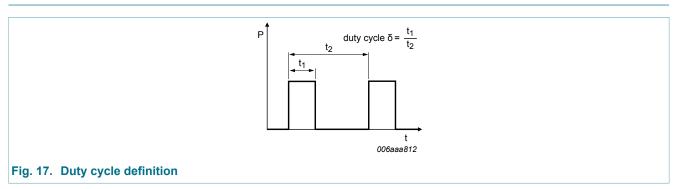


Fig. 16. Source current as a function of source-drain voltage; typical values

### 8. Test information

 $V_{GS} = 0 V$ 



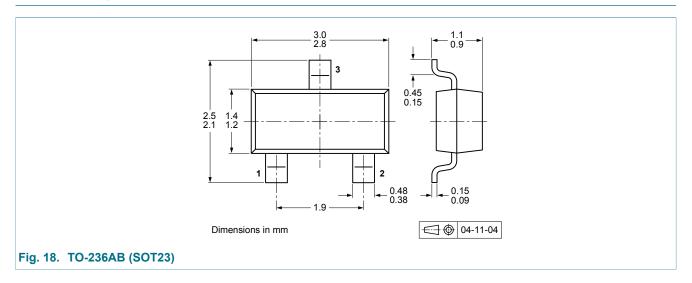
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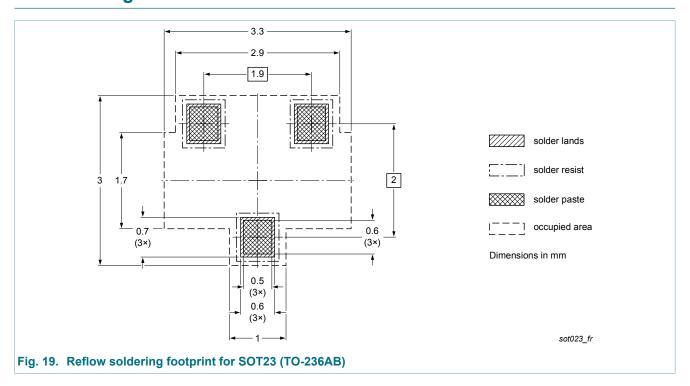
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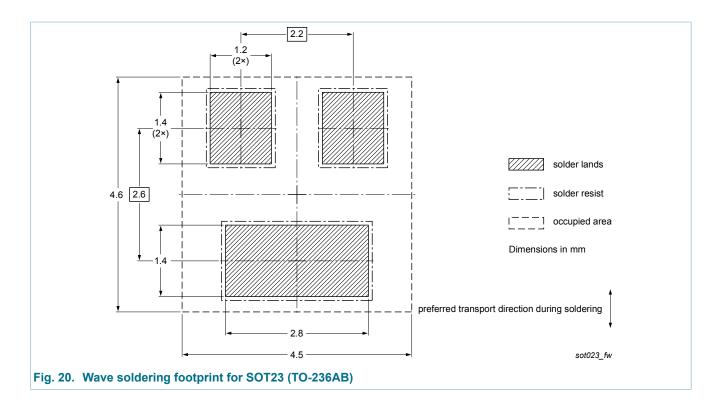
## 9. Package outline



## 10. Soldering



#### 30 V, single N-channel Trench MOSFET



## 11. Revision history

Table 8. Revision history

| Data sheet ID | Release date | Data sheet status  | Change notice | Supersedes |
|---------------|--------------|--------------------|---------------|------------|
| PMV185XN v.1  | 20120803     | Product data sheet | -             | -          |

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|--------------------------------------|--------------------|---|
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